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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANT(S):

Alex S. Koh et al

GROUP ART UNIT:

2123

APPLN. NO.;

09/847,487

EXAMINER:

Kandasamy Thangavelu

FILED:

May 2, 2001

TITLE:

METHOD FOR PRODUCTIVE TEST PATTERNS FOR TESTING AN INTEGRATED

CIRCUIT

Certificate of Transmission under 37 CFR 1.8

I hereby certify that this correspondence is being facsimile

transmitted to the Patent and Trademark Office.

Stacie Herrera

Printed Name of Person Signing Certificate

NOTICE OF APPEAL FROM THE EXAMINER TO THE **BOARD OF PATENT APPEALS AND INTERFERENCES**

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SIR:

In accordance with 37 CFR 1.191, applicant hereby appeals to the Board of Patent Appeals and Interferences from the last decision of the examiner. The Commissioner is hereby authorized to charge any fees which may be required, or credit any overpayment to Deposit Account No. 503079, Freescale Semiconductor, Inc. This Notice is submitted in duplicate.

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Respectfully submitted,

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